Pressure-driven Lifshitz transition in type-II Dirac semimetal NiTe₂

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Band engineering in layered transition metal dichalcogenides (TMDs) leads to a variety of emergent phenomena and has obtained considerable attention recently. Transition metal ditelluride NiTe₂ has been discovered experimentally to be a type-II Dirac semimetal at ambient pressure, and was predicted to display superconductivity in the monolayer limit. Here we systematically investigate the structural and electronic properties of type-II Dirac semimetal NiTe₂ under high pressure. Room-temperature synchrotron x-ray diffraction and Raman scattering measurements reveal the stability of the pristine hexagonal phase up to 52.2 GPa, whereas both the pressure coefficient and linewidth of Raman mode E_g exhibit anomalies at a critical pressure $P_c \sim 16$ GPa. Meantime, Hall resistivity measurement indicates that the hole-dominated behavior maintains up to 15.6 GPa and transforms into electron-dominated behavior at higher pressures. Our findings consistently demonstrate a pressure-induced Lifshitz transition in type-II Dirac semimetal NiTe₂.

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Layered transition metal dichalcogenides (TMDs) have attracted extensive interest because of their rich physical properties [1-3] and potential applications in electronics and optoelectronics [4]. TMDs have a general formula MX_2 (M =transition metal; X = S, Se, or Te), where the adjacent X-M-X layers are held together by van der Waals interactions [5]. During the past several years, accompanied by exploration of novel topological electronic states, much attention has been paid to the TMDs focusing on their nontrivial band topology, leading to the theoretical prediction and experimental discovery of type-II Weyl semimetal in WTe₂ [6] and MoTe₂ [7], as well as type-II Dirac semimetal in PtSe₂ [8], PdTe₂ [9], and PtTe₂ [10]. Theoretically, the type-II Dirac (Weyl) semimetals possess highly tilted Dirac (Weyl) cones along certain momentum directions due to the violation of Lorentz invariance [6]. The linear energy dispersions of Dirac (Weyl) cones normally result in an ultrahigh carrier mobility and large nonsaturating magnetoresistance [11,12], rendering promising applications in electronics and spintronics. Very recently, NiTe₂ has been reported to be a type-II Dirac semimetal through quantum oscillation measurements and band structure calculations [13]. The topological feature in NiTe₂ has been further observed via spin- and angle-resolved photoemission spectroscopy [14]. It is found that the Dirac points of NiTe₂ are located just at ~0.02 eV above the Fermi level, more closely than its homologues PdTe₂ (0.5 eV) [15], $PtTe_2$ (0.8 eV) [10], and $PtSe_2$ (1.2 eV) [16], which may

provide an advantageous platform to study the topological properties of the type-II Dirac semimetals [13,14]. More interestingly, based on *ab initio* calculations, it was predicted that monolayer NiTe₂ is an intrinsic superconductor with a critical temperature $T_c \sim 5.7$ K, while bilayer NiTe₂ intercalated with lithium displays a two-gap superconductivity with a $T_c \sim 11.3$ K [17].

As one of the fundamental state parameters, pressure has been proved to be an effective and clean way to tune the electronic states of TMDs according to the discoveries such as pressure-induced superconductivity, pressure-induced electronic topological transition (ETT), or Lifshitz transition, etc. [18–21]. In this work, we performed high-pressure x-ray diffraction (XRD), Raman scattering, and electrical transport measurements on type-II Dirac semimetal NiTe₂. With increasing pressure up to 71.2 GPa, although no traces of superconductivity have been detected down to 1.8 K, we demonstrate a Lifshitz transition instead. The Lifshitz transition, occurring around $P_c \sim 16$ GPa, is not only reflected in the anomalies of the pressure coefficient and linewidth of the Raman mode E_g , but also revealed by the sign change of the Hall coefficient.

Experimental details are presented in the Supplemental Material [22]. The synthesized NiTe₂ single crystals are characterized by the XRD and energy-dispersive x-ray spectroscopy (EDXS) experiments at ambient pressure. As illustrated in Supplemental Material, Fig. S1(a), bulk NiTe₂ crystallizes in the layered CdI₂-type structure with space group P-3m1 (No. 164). Figure S1(b) shows the XRD patterns of NiTe₂ single crystal. The observation of only (00*l*) diffraction peaks indicates a *c*-axis orientation of the as-grown crystals. Figure S1(c) displays the EDXS characterization,

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FIG. 1. High-pressure powder synchrotron XRD patterns of NiTe₂ at room temperature ($\lambda = 0.4133$ Å). (a) Representative diffraction patterns under compression up to 52.2 GPa. Le Bail refinement with a *P*-3*m*1 space group is shown for 0.5 GPa. The open circles and red line represent the observed and calculated data, respectively. The vertical bars indicate the position of Bragg peaks. (b) The pressure-dependent lattice parameters *a* and *c*, and axis ratio c/a. (c) Volume as a function of pressure. The open circles denote the data of the hexagonal (*P*-3*m*1, *Z* = 1) phase. The solid line is the fitting result based on the third-order Birch-Murnaghan equation of state.

from which the real composition is determined to be NiTe_{1.98}. Powder XRD patterns confirm the pure hexagonal phase [see Fig. S1(d)]. The lattice parameters extracted via Le Bail fitting are a = 3.8776 Å, c = 5.2653 Å, in agreement with the previous report [13]. These results demonstrate the high quality of the sample used here.

To check the structural stability of pristine NiTe₂ under pressure, we performed high-pressure powder XRD measurements at room temperature. As shown in Fig. 1(a), all the XRD peaks continuously shift towards higher angles without new peaks appearing when the pressure increases up to 52.2 GPa, indicating the absence of structural phase transition in the pressurized NiTe2. The XRD patterns under compression can be well indexed with the hexagonal P-3m1 phase in Le Bail refinements. A representative refinement of the XRD patterns at 0.5 GPa is presented at the bottom of Fig. 1(a). The fitting results of weighted profile factor $R_{\rm WP}$, profile factor $R_{\rm P}$, and goodness of fit χ^2 are 2.61%, 1.37%, and 0.08, respectively. The extracted lattice parameters a and c, and axis ratio c/a, decrease monotonically with increasing pressure, as shown in Fig. 1(b). Upon compression from 0.5 to 52.2 GPa, the parameters a and c decrease by 7.2% and 13.9%, respectively, revealing a large anisotropy of axial compressibility due to the quasi-two-dimensional nature of the lattice. Meanwhile, the overall volume decreases by 25.9%. Figure 1(c) shows the pressure (P) dependence of volume (V), which can be fitted by the third-order Birch-Murnaghan equation of state [26]: $P = \frac{3}{2}B_0[(V_0/V)^{\frac{7}{3}} - (V_0/V)^{\frac{5}{3}}]\{1 + \frac{3}{4}(B'_0 - 4)[(V_0/V)^{\frac{2}{3}} - 1]\},$ where V_0 , B_0 , and B'_0 are the volume, bulk modulus -V/(dV/dP), and first-order derivative of the bulk



FIG. 2. (a) Pressure-dependent Raman spectra of NiTe₂ single crystal at room temperature. (b) The frequency of the E_g mode as a function of pressure. The red solid lines represent linear fittings. Inset: The schematic view of Raman mode E_g . (c) Pressure dependence of FWHM of the E_g mode. The black solid lines are guides to the eyes.

modulus at zero pressure, respectively. The fitting yields $V_0 = 67.9 \pm 0.5 \text{ Å}^3$, $B_0 = 53.3 \pm 7.4 \text{ GPa}$, and $B'_0 = 8.1 \pm 0.9$.

Raman spectroscopy is an effective and powerful tool in detecting lattice vibrations, which can provide information including electron-phonon coupling, weak lattice distortion, and/or structural transition. Bulk NiTe₂ displays a similar 1T structure of TiTe2 and nine vibrational modes due to the same irreducible representation at the gamma point of the Brillouin zone [27]. Figure 2(a) shows the selective room-temperature Raman spectra of NiTe₂ single crystal at various pressures. At 0.6 GPa, one vibrational mode that can be assigned to the E_g mode is detected at ~84 cm⁻¹ [13]. As illustrated in the inset of Fig. 2(b), the E_g mode involves in-plane atomic vibrations, with the top and bottom Te atoms moving in opposite directions [28]. In line with the stability of the pristine hexagonal phase as revealed by the XRD measurements, the E_g mode shifts gradually to higher frequencies without new peaks appearing with increasing pressure up to 35.7 GPa. Figures 2(b) and 2(c) display the pressure-dependent frequency and full width at half maximum (FWHM) obtained from Lorentz fittings of the E_g mode. With increasing pressure, one can see that the Raman frequency increases linearly but with different slopes below and above a critical pressure $P_{\rm c} \sim 16$ GPa, as indicated by an arrow in Fig. 2(b). Similar to Refs. [29,30], the Grüneisen parameter $\gamma_i = (B_0/\omega_i) \times$ $(d\omega_i/dP)$, with ω_i the *i*th phonon mode frequency, and B_0 , the bulk modulus at zero pressure, is calculated for the E_g mode. Both the pressure coefficients and Grüneisen parameters before and after P_c are shown in Table S1 (see Supplemental Material [22]). Along with the change of pressure coefficient $(d\omega/dP)$ from 2.07 to 0.99 cm⁻¹ GPa⁻¹, the pressuredependent FWHM exhibits a rather pronounced anomaly around P_c [see Fig. 2(c)]. As we know, the Raman linewidth



FIG. 3. (a) In-plane longitudinal resistivity curves $\rho(T)$ of NiTe₂ single crystal at various pressures up to 71.2 GPa. (b) Resistivity at 10 and 300 K as a function of pressure. (c) Representative magnetoresistance curves at 10 K under pressure.

is inversely proportional to the lifetime of the phonon mode, which involves information of not only phonon-phonon interactions but also the excitation-phonon interactions such as electron-phonon and spin-phonon coupling [31]. As the pressure increases, the linewidth of the phonon modes will generally increase. However, for the pressurized NiTe₂, the FWHM of the E_g mode exhibits an abrupt drop at pressures of 14.8–18.0 GPa. Without a structural transition occurring, the existence of anomalies in the phonon spectrum is reminiscent of a pressure-induced ETT or Lifshitz transition, which has been observed in some other transition metal chalcogenides, such as Bi₂Se₃ [32], Bi₂Te₃ [33], Sb₂Te₃ [34], Sb₂Se₃ [35], and TiTe₂ [27].

An ETT or Lifshitz transition occurs when an extreme of the electronic band structure crosses the Fermi energy level, which is associated to a van Hove singularity in the density of states [36]. Therefore, we further conducted highpressure electrical resistivity measurements to search for possible evidence of the Lifshitz transition. Figure 3(a) shows the temperature-dependent resistivity $\rho(T)$ at various pressures. At 0.7 GPa, a metallic behavior is clearly presented in the temperature region from 1.8 to 300 K, similar to that at ambient condition [13]. The metallic behavior maintains with increasing pressure up to 71.2 GPa and no traces of superconductivity are detected down to 1.8 K. Note that the recent high-pressure experiments in polycrystalline NiTe₂ discover a superconducting transition without zero resistance between 12.0 and 54.5 GPa [37]. We also note that the possible impurities and defects are superconducting under pressure, such as element Te [38]. Meantime, the $\rho(T)$ curve is monotonically shifted upward except in the low-pressure region. The resistivity and magnetoresistance, MR = $[(\rho(H) - \rho(0))]/\rho(0) \times 100\%$, at 10 K under various pressure are displayed in Figs. 3(b) and 3(c), respectively. Note that the resistivity of 300 K in Fig. 3(b)shows a minimum around 5 GPa. Since no structural phase transition occurs under high pressure and the structural param-



FIG. 4. (a,b) Pressure dependence of transversal Hall resistivity curves $\rho_{xy}(H)$ of NiTe₂ single crystal at 10 K. (c) Hall coefficient $R_{\rm H}$ as a function of pressure. The $R_{\rm H}$ is determined from the initial slope of $\rho_{xy}(H)$ at $H \rightarrow 0$.

eter c/a concomitantly displays a slope change around 5 GPa (see Fig. 1), the anomaly around 5 GPa might be attributed to an ETT. The MR is almost completely suppressed at pressures above 15.6 GPa, but beyond that, no more anomalies associated with the Lifshitz transition can be discerned from Fig. 3.

High-pressure Hall resistivity measurements were further carried out to extract the evolution of charge carriers in the pressurized NiTe₂. Figures 4(a) and 4(b) show the selective Hall resistivity curves $\rho_{xy}(H)$ measured at 10 K under various pressures, where the magnetic field H is applied perpendicular to the *ab* plane. At 0.7 GPa, the $\rho_{xy}(H)$ curve exhibits a nonlinear feature with positive slope, indicating a hole-dominated multiband feature of the electrical transport in agreement with that at ambient pressure [39]. The Hall coefficient $R_{\rm H}$, extracted from the slope of $\rho_{xy}(H)$ around zero field, decreases monotonically with increasing pressure and changes from positive to negative above 15.6 GPa [see Fig. 4(c)]. The sign change of the $R_{\rm H}$ demonstrates that the hole-dominated behavior maintains up to 15.6 GPa and transforms into electron-dominated behavior at higher pressures, which further evidences the change of the Fermi surface and could be viewed as a signature of the Lifshitz transition. We note that the temperature-induced Lifshitz transition in ZrTe₅ also involves the change of charge carrier type [40], which is very similar to our case.

In summary, we have systematically investigated the pressure effect on the structural and electronic properties of type-II Dirac semimetal NiTe₂ by combining synchrotron x-ray diffraction, Raman scattering, and electrical transport measurements. Although the x-ray diffraction results show the stability of pristine hexagonal structure up to 52.2 GPa, both pressure coefficient and linewidth of Raman mode E_g display abnormal behaviors across $P_c \sim 16$ GPa. Our findings unveil a pressure-induced Lifshitz transition of NiTe₂ at P_c , which is further supported by the change of charge carrier type through electrical transport analysis.

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